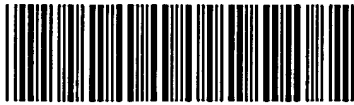


Search Notes

Application/Control No.

10/662,003

Examiner

Young J. Kim

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

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SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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| Updated Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) | 9/12/2006 | YJK |
| STN Commercial Databases (Biosis, Medline, Embase, Embal, SciSearch, CAPlus, Registry) see enclosed for search strategy | 9/12/2006 | YJK |
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